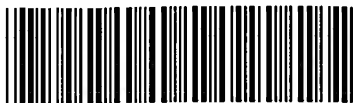


Search Notes

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10/660,950

Examiner

Maikhanh Nguyen

Applicant(s)/Patent under
Reexamination

O'DONNELL, SHAWN

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	505	10/22/2005	MK
715	506,507	10/22/2005	MK
707	10.	10/22/2005	MK
Updated	Search	5/16/2006	MK
Updated	Search	2/19/2007	MK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search	10/22/2005	MK
West Search	10/22/2005	MK
NPL (IEEE)	10/22/2005	MK
West Updated (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB) See Search History Printout	5/16/2006	MK
West Updated (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB) See Search History Printout	2/19/2007	MK